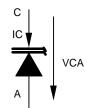


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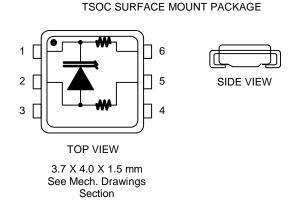
SPECIAL FEATURES

- Zener characteristic with voltage snap-back to protect against ESD hits
- High avalanche voltage, low leakage and low capacitance avoid signal attenuation
- Compatible to all 5V logic families
- Space saving, low inductance TSOC surface mount package
- On-chip 5Ω resistors for isolation at both anode and cathode terminals
- Industrial temperature range

SYMBOL AND CONVENTIONS



PACKAGE OUTLINE



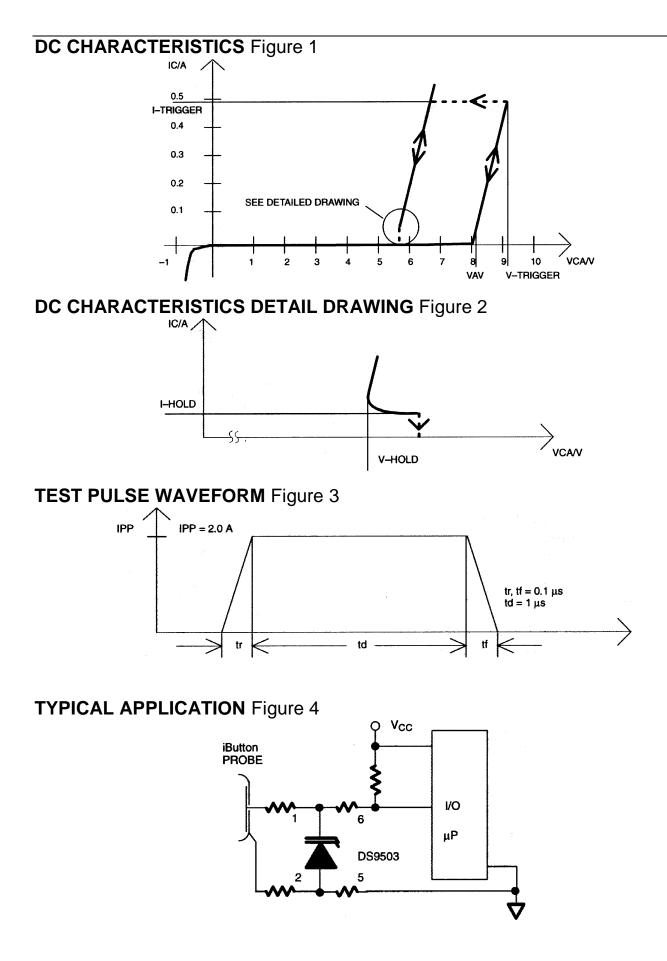
ORDERING INFORMATION

DS9503P 6-lead TSOC package

DESCRIPTION

This DS9503 is designed as an ESD protection device for 1–Wire MicroLAN interfaces. In contrast to the DS9502, the DS9503 includes two 5 Ω isolation resistors on chip. Although 5 Ω are negligible during communication, they represent a high impedance relative to the conducting diode during an ESD event. Thus, the diode absorbs the energy while the resistors further isolate and protect the circuit at the other side of the package. If used with circuits that already have a strong ESD–protection at their I/O port, the ESD protection level is raised to more that 27 kV (IEC 801–2 Reference model). In case of abnormal ESD hits beyond its maximum ratings the DS9503 will eventually fail "short" thus preventing further damage.

During normal operation the DS9503 behaves like a regular 7.5V Zener Diode. When the voltage exceeds the trigger voltage, the I/V characteristic of the device will "snapback" allowing the same or higher amount of current to flow, but at a significantly lower voltage. As long as a minimum current or voltage is maintained, the device will stay in the "snapback mode". If the voltage or the current falls below the holding voltage or holding current, the device will abruptly change to its normal mode and conduct only a small leakage current.



PHYSICAL SPECIFICATIONS

Size
Weight

See mechanical drawing 0.5 grams

ABSOLUTE MAXIMUM RATINGS*

Operating Temperature Storage Temperature Soldering Temperature Continuous DC Current Through Package -40°C to +85°C -55°C to +125°C 260°C for 10 seconds 80 mA

* This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability

ELECTRICAL CHARACTERISTICS				(-40°C to +85°C)			
PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES	
Leakage Current	IL		30	100	nA	2	
Avalanche Voltage	V _{AV}	7.4		7.8	V	1,3	
Trigger Voltage	V _{TRIGGER}		9.0	9.5	V	1	
Trigger Current	I _{TRIGGER}		600	1000	mA		
Holding Voltage	V _{HOLD}	5.5			V	1	
Holding Current	I _{HOLD}	30			mA		
Forward Voltage (-10 mA)	V _F		-0.7	-0.8	V	4	
Forward Current (-0.7V)	$I_{\rm F}$		-10	-100	mA	4	
Maximum Peak Current	I_{PP}		2.0		А	5	
Continuous Current Through Diode	I _{CC}			±80	mA		
Isolation Resistance	RI		5		Ω		
CAPACITANCE (t _A =25°C)							
D & D & METER	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~						

$(t_A=25^\circ)$					₄=25°C)	
PARAMETER	SYMBOL	MIN	ТҮР	MAX	UNITS	NOTES
Junction Capacitance (5V)	C _{J5}		40		pF	1
Junction Capacitance (0V)	C_{J0}		70		pF	1

THERMAL RESISTANCE

PARAMETER	SYMBOL	MIN	ТҮР	MAX	UNITS	NOTES
Junction To Package	$R_{\Theta JC}$			75	K/W	
Junction To Ambient	R _{OJA}			200	K/W	

NOTES:

- 1. All voltages are referenced from Cathode to Anode.
- 2. At 7.0V.
- 3. At 0.3 μA.
- 4. Typical values at room temperature.
- 5. See pulse specification.